

ON Semiconductor® NDS331N N-Channel Logic Level Enhancement Mode Field Effect Transistor

General Description

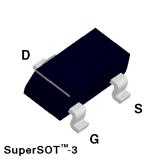
Features

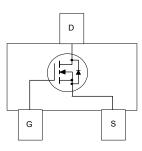
These N-Channel logic level enhancement mode power field effect transistors are produced using ON Semiconductor's proprietary, high cell density, DMOS technology. This very high density process is especially tailored to minimize onstate resistance. These devices are particularly suited for low voltage applications in notebook computers, portable phones, PCMCIA cards, and other battery powered circuits where fast switching, and low in-line power loss are needed in a very small outline surface mount package.

 $R_{\rm DS(ON)} = 0.16 \ \Omega \ @ \ V_{\rm GS} = 4.5 \ V.$ Industry standard outline SQT-23 surface mount package

1.3 A, 20 V. $R_{\rm DS(ON)}$ = 0.21 Ω @ V_{GS} = 2.7 V

- Industry standard outline SOT-23 surface mount package using poprietary SuperSOT[™]-3 design for superior thermal and electrical capabilities.
- High density cell design for extremely low R_{DS(ON)}.
- Exceptional on-resistance and maximum DC current capability.





Absolute Maximum Ratings $T_{A} = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter		NDS331N	
V _{DSS}	Drain-Source Voltage		20	V
V _{GSS}	Gate-Source Voltage - Continuous		8	V
I _D	Maximum Drain Current - Continuous	(Note 1a)	1.3	А
	- Pulsed		10	
P _D	Maximum Power Dissipation	(Note 1a)	0.5	W
		(Note 1b)	0.46	
T_,T _{stg}	Operating and Storage Temperature Range		-55 to 150	°C
THERMA	L CHARACTERISTICS			
R _{θJA}	Thermal Resistance, Junction-to-Ambient	(Note 1a)	250	°C/W
R _{θJC}	Thermal Resistance, Junction-to-Case	(Note 1)	75	°C/W

Symbol	Parameter	Conditions		Min	Тур	Max	Units
OFF CHA	RACTERISTICS						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250 μA		20			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 16 V, V _{GS} = 0 V				1	μA
			T _J =125°C			10	μA
I _{GSSF}	Gate - Body Leakage, Forward	V _{GS} = 8 V, V _{DS} = 0 V				100	nA
I _{GSSR}	Gate - Body Leakage, Reverse	V _{GS} = -8 V, V _{DS} = 0 V				-100	nA
ON CHAR	ACTERISTICS (Note 2)						
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 250 μA		0.5	0.7	1	V
			T _J =125°C	0.3	0.53	0.8	
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} = 2.7 V, I _D = 1.3 A			0.15	0.21	Ω
			T _J =125°C		0.24	0.4	
		$V_{\rm GS}$ = 4.5 V, I _D = 1.5 A			0.11	0.16	
I _{D(ON)}	On-State Drain Current	V_{GS} = 2.7 V, V_{DS} = 5 V		3			A
		V_{GS} = 4.5 V, V_{DS} = 5 V		4			
9 _{FS}	Forward Transconductance	V _{DS} = 5 V, I _D = 1.3 A,			3.5		S
DYNAMIC	CHARACTERISTICS						
C _{iss}	Input Capacitance	$V_{DS} = 10 \text{ V}, \text{ V}_{GS} = 0 \text{ V},$ f = 1.0 MHz			162		pF
C _{oss}	Output Capacitance				85		pF
C _{rss}	Reverse Transfer Capacitance				28		pF
SWITCHI	NG CHARACTERISTICS (Note 2)						
t _{D(on)}	Turn - On Delay Time	V _{DD} = 5 V, I _D = 1 A,			5	20	ns
t,	Turn - On Rise Time	V_{GS} = 5 V, R_{Gen} = 6 Ω			25	40	ns
t _{D(off)}	Turn - Off Delay Time				10	20	ns
t _r	Turn - Off Fall Time				5	20	ns
Q _g	Total Gate Charge	$V_{DS} = 5 V, I_D = 1.3 A,$ $V_{GS} = 4.5 V$			3.5	5	nC
Q _{gs}	Gate-Source Charge				0.3		nC
Q_{gd}	Gate-Drain Charge				1		nC

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Electrical Characteristics (T _A = 25°C unless otherwise noted)									
Symbol	Parameter	Conditions	Min	Тур	Мах	Units			
DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS									
I _s	Maximum Continuous Drain-Source Diode Forward Current				0.42	А			
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current				10	А			
V _{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 V, I_{S} = 0.42 A (Note 2)$		0.8	1.2	V			
Notes:		-	•	•	•	·			

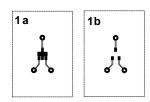
1. R_{gub} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{gub} is guaranteed by design while R_{gub} is determined by the user's board design.

 $P_{D}(t) = \frac{T_{J} - T_{A}}{R_{\theta J} \, \underline{k}^{t}} = \frac{T_{J} - T_{A}}{R_{\theta J} \, \underline{c}^{t} R_{\theta C} \underline{k}^{t}} = I_{D}^{2}(t) \times R_{DS(ON)} g_{T_{J}}$

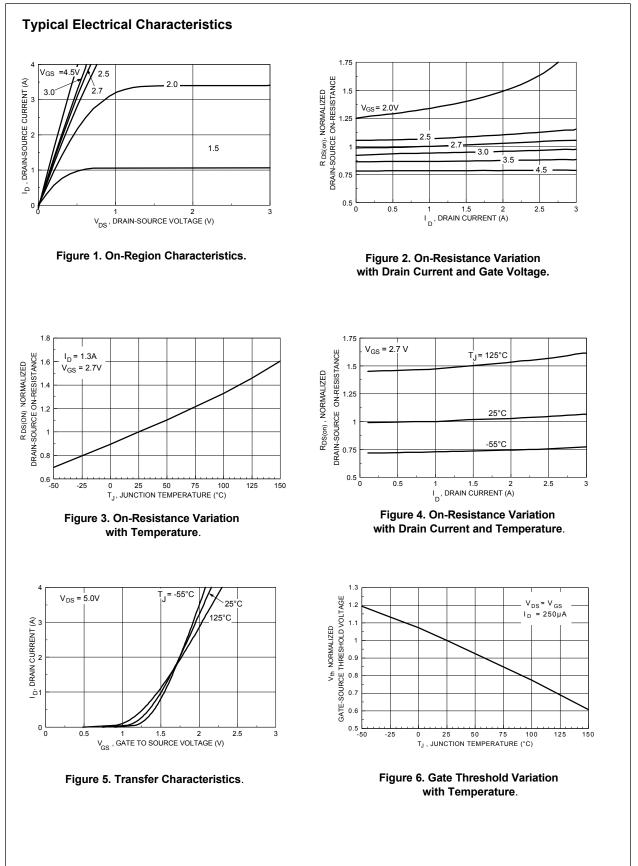
Typical $R_{_{B^{JA}}}$ using the board layouts shown below on 4.5"x5" FR-4 PCB in a still air environment:

a. 250°C/W when mounted on a 0.02 in² pad of 2oz copper.

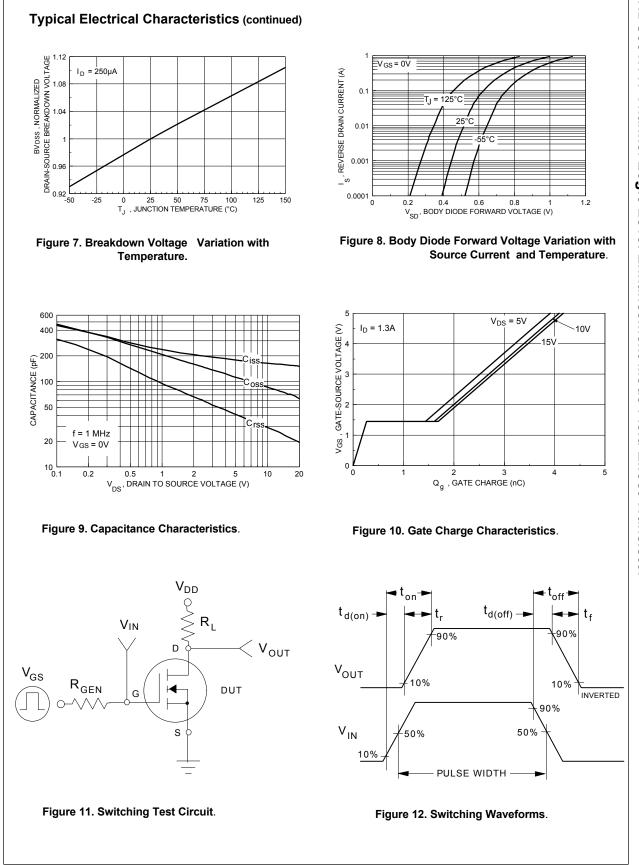
b. 270°C/W when mounted on a 0.001 in² pad of 2oz copper.



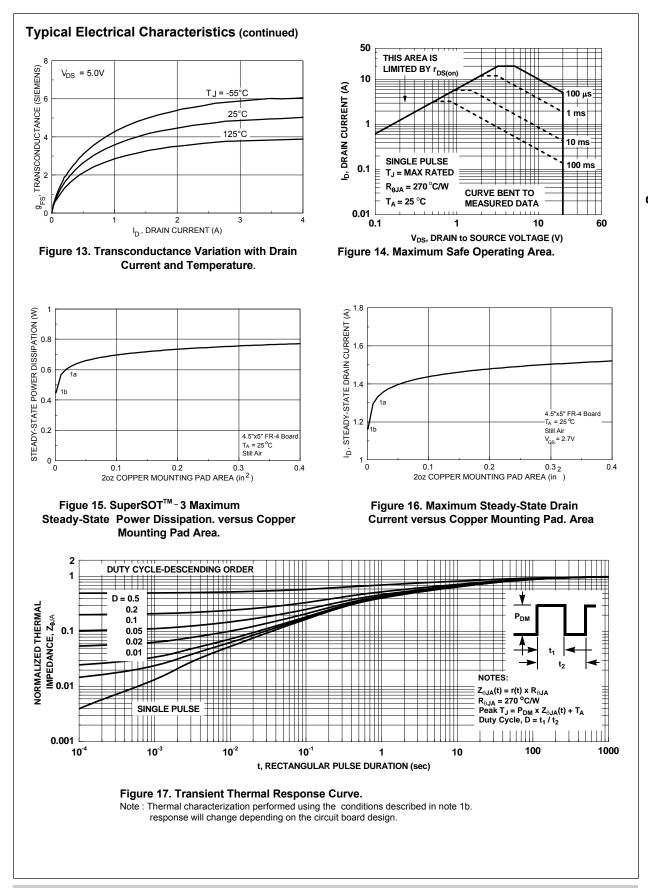
 $\label{eq:Scale 1: 1 on letter size paper} Scale 1: 1 on letter size paper \\ 2. Pulse Test: Pulse Width \leq 300 \mu s, Duty Cycle \leq 2.0\%. \\$



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